

**Search Notes**

Application/Control No.

10/053,079

Examiner

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Applicant(s)/Patent under  
Reexamination

FLEISCHER ET AL.

Art Unit

2664

**SEARCHED**

Class	Subclass	Date	Examiner
370	238	10/11/2005	BQN
370	238.1	10/11/2005	BQN
370	218	10/11/2005	BQN
370	217	10/11/2005	BQN
370	225	10/11/2005	BQN
370	228	10/11/2005	BQN
370	237	10/11/2005	BQN
709	239	10/11/2005	BQN
701	202	10/11/2005	BQN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
709	239	10/11/2005	BQN
701	202	10/11/2005	BQN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM-TDB) see more on search history.	10/11/2005	BQN
Consulted with Wellington Chin	10/11/2005	BQN